

Zeners 1N4728A - 1N4764A

Absolute Maximum Ratings * $T_A = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Value	Units
P_D	Power Dissipation @ $T_L \leq 50^\circ\text{C}$, Lead Length = 3/8"	1.0	W
	Derate above 50°C	6.67	mW/ $^\circ\text{C}$
T_J, T_{STG}	Operating and Storage Temperature Range	-65 to +200	$^\circ\text{C}$

* These ratings are limiting values above which the serviceability of the diode may be impaired.

Tolerance = 5%



Electrical Characteristics $T_A = 25^\circ\text{C}$ unless otherwise noted

Device	V_Z (V) @ I_Z (Note 1)			Test Current I_Z (mA)	Max. Zener Impedance			Leakage Current	
	Min.	Typ.	Max.		Z_Z @ I_Z (Ω)	Z_{ZK} @ I_{ZK} (Ω)	I_{ZK} (mA)	I_R (μA)	V_R (V)
1N4728A	3.315	3.3	3.465	76	10	400	1	100	1
1N4729A	3.42	3.6	3.78	69	10	400	1	100	1
1N4730A	3.705	3.9	4.095	64	9	400	1	50	1
1N4731A	4.085	4.3	4.515	58	9	400	1	10	1
1N4732A	4.465	4.7	4.935	53	8	500	1	10	1
1N4733A	4.845	5.1	5.355	49	7	550	1	10	1
1N4734A	5.32	5.6	5.88	45	5	600	1	10	2
1N4735A	5.89	6.2	6.51	41	2	700	1	10	3
1N4736A	6.46	6.8	7.14	37	3.5	700	1	10	4
1N4737A	7.125	7.5	7.875	34	4	700	0.5	10	5
1N4738A	7.79	8.2	8.61	31	4.5	700	0.5	10	6
1N4739A	8.645	9.1	9.555	28	5	700	0.5	10	7
1N4740A	9.5	10	10.5	25	7	700	0.25	10	7.6
1N4741A	10.45	11	11.55	23	8	700	0.25	5	8.4
1N4742A	11.4	12	12.6	21	9	700	0.25	5	9.1
1N4743A	12.35	13	13.65	19	10	700	0.25	5	9.9
1N4744A	14.25	15	15.75	17	14	700	0.25	5	11.4
1N4745A	15.2	16	16.8	15.5	16	700	0.25	5	12.2
1N4746A	17.1	18	18.9	14	20	700	0.25	5	13.7
1N4747A	19	20	21	12.5	22	700	0.25	5	15.2
1N4748A	20.9	22	23.1	11.5	23	750	0.25	5	16.7
1N4749A	22.8	24	25.2	10.5	25	750	0.25	5	18.2
1N4750A	25.65	27	28.35	9.5	35	750	0.25	5	20.6
1N4751A	28.5	30	31.5	8.5	40	1000	0.25	5	22.8
1N4752A	31.35	33	34.65	7.5	45	1000	0.25	5	25.1
1N4753A	34.2	36	37.8	7	50	1000	0.25	5	27.4
1N4754A	37.05	39	40.95	6.5	60	1000	0.25	5	29.7
1N4755A	40.85	43	45.15	6	70	1500	0.25	5	32.7
1N4756A	44.65	47	49.35	5.5	80	1500	0.25	5	35.8
1N4757A	48.45	51	53.55	5	95	1500	0.25	5	38.8

Electrical Characteristics (Continued) $T_A=25^\circ\text{C}$ unless otherwise noted

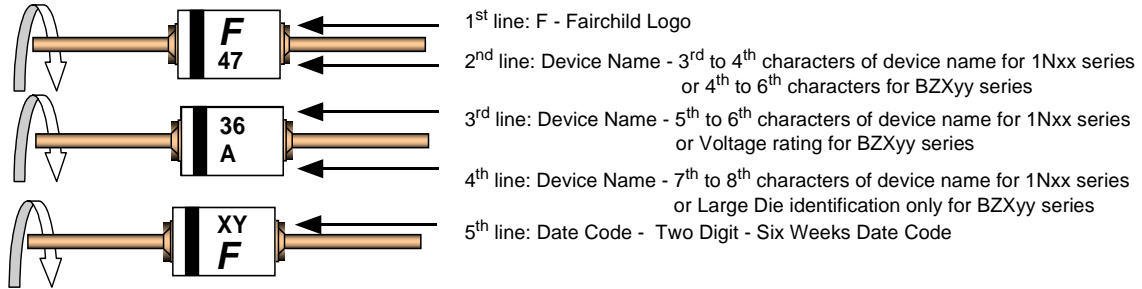
Device	V_Z (V) @ I_Z (Note 1)			Test Current I_Z (mA)	Max. Zener Impedance			Leakage Current	
	Min.	Typ.	Max.		Z_Z @ I_Z (Ω)	Z_{ZK} @ I_{ZK} (Ω)	I_{ZK} (mA)	I_R (μA)	V_R (V)
1N4758A	53.2	56	58.8	4.5	110	2000	0.25	5	42.6
1N4759A	58.9	62	65.1	4	125	2000	0.25	5	47.1
1N4760A	64.6	68	71.4	3.7	150	2000	0.25	5	51.7
1N4761A	71.25	75	78.75	3.3	175	2000	0.25	5	56
1N4762A	77.9	82	86.1	3	200	3000	0.25	5	62.2
1N4763A	86.45	91	95.55	2.8	250	3000	0.25	5	69.2
1N4764A	95	100	105	2.5	350	3000	0.25	5	76

 V_F Forward Voltage = 1.2V Max @ $I_F = 200\text{mA}$ **Notes:**1. Zener Voltage (V_Z)The zener voltage is measured with the device junction in the thermal equilibrium at the lead temperature (T_L) at $30^\circ\text{C} \pm 1^\circ\text{C}$ and 3/8" lead length.

Top Mark Information

Device	Line 1	Line 2	Line 3	Line 4	Line 5
1N4728A	LOGO	47	28	A	XY
1N4729A	LOGO	47	29	A	XY
1N4730A	LOGO	47	30	A	XY
1N4731A	LOGO	47	31	A	XY
1N4732A	LOGO	47	32	A	XY
1N4733A	LOGO	47	33	A	XY
1N4734A	LOGO	47	34	A	XY
1N4735A	LOGO	47	35	A	XY
1N4736A	LOGO	47	36	A	XY
1N4737A	LOGO	47	37	A	XY
1N4738A	LOGO	47	38	A	XY
1N4739A	LOGO	47	39	A	XY
1N4740A	LOGO	47	40	A	XY
1N4741A	LOGO	47	41	A	XY
1N4742A	LOGO	47	42	A	XY
1N4743A	LOGO	47	43	A	XY
1N4744A	LOGO	47	44	A	XY
1N4745A	LOGO	47	45	A	XY
1N4746A	LOGO	47	46	A	XY
1N4747A	LOGO	47	47	A	XY
1N4748A	LOGO	47	48	A	XY
1N4749A	LOGO	47	49	A	XY
1N4750A	LOGO	47	50	A	XY
1N4751A	LOGO	47	51	A	XY
1N4752A	LOGO	47	52	A	XY
1N4753A	LOGO	47	53	A	XY
1N4754A	LOGO	47	54	A	XY
1N4755A	LOGO	47	55	A	XY
1N4756A	LOGO	47	56	A	XY
1N4757A	LOGO	47	57	A	XY
1N4758A	LOGO	47	58	A	XY
1N4759A	LOGO	47	59	A	XY
1N4760A	LOGO	47	60	A	XY
1N4761A	LOGO	47	61	A	XY
1N4762A	LOGO	47	62	A	XY
1N4763A	LOGO	47	63	A	XY
1N4764A	LOGO	47	64	A	XY

Top Mark Information (Continued)



General Requirements:

- 1.0 Cathod Band
- 2.0 First Line: F - Fairchild Logo
- 3.0 Second Line: Device name - For 1Nxx series: 3rd to 4th characters of the device name.
For BZxx series: 4th to 6th characters of the device name.
- 4.0 Third Line: Device name - For 1Nxx series: 5th to 6th characters of the device name.
For BZXyy series: Voltage rating
- 5.0 Third Line: Device name - For 1Nxx series: 7th to 8th characters of the device name.
(the 8th character is the large die identification)
For BZXyy series: Large Die Identification character
- 6.0 Fourth Line: Date Code - Two Digit - Six Weeks Date Code
Where: X represents the last digit of the calendar year
Y represents the Six weeks numeric code
- 7.0 Devices shall be marked as required in the device specification (PID or FSC Test Spec).
- 8.0 Maximum no. of marking lines: 5
- 9.0 Maximum no. of digits per line: 3
- 10.0 FSC logo must be 20 % taller than the alphanumeric marking and should occupy the 2 characters of the specified line.
- 11.0 Marking Font: Arial (Except FSC Logo)
- 12.0 First character of each marking line must be aligned vertically

TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

ACEx™	FACT Quiet Series™	ImpliedDisconnect™	PACMAN™	SPM™
ActiveArray™	FAST®	ISOPLANAR™	POP™	Stealth™
Bottomless™	FASTr™	LittleFET™	Power247™	SuperFET™
CoolFET™	FPST™	MICROCOUPLER™	PowerSaver™	SuperSOT™-3
CROSSVOLT™	FRFET™	MicroFET™	PowerTrench®	SuperSOT™-6
DOMET™	GlobalOptoisolator™	MicroPak™	QFET®	SuperSOT™-8
EcoSPARK™	GTO™	MICROWIRE™	QS™	SyncFET™
E ² C MOS™	HiSeC™	MSX™	QT Optoelectronics™	TinyLogic®
EnSigna™	µC™	MSXPro™	Quiet Series™	TINYOPTO™
FACT™	i-Lo™	OCX™	RapidConfigure™	TruTranslation™
Across the board. Around the world.™	OCXPro™	OCXPro™	RapidConnect™	UHC™
The Power Franchise®	OPTOLOGIC®	OPTOLOGIC®	SILENT SWITCHER®	UltraFET®
Programmable Active Droop™	OPTOPLANAR™	OPTOPLANAR™	SMART START™	VCX™

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.
2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.